

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10661612	COYNE ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Pardo, Thuy N	2627	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	10, 101, 104.1	5/31/2007	TP
709	202, 237	5/31/2007	TP
707	102, 103R	12/21/2007	TP
707	4	8/15/2008	TP
709	224	8/15/2008	TP
709	227	5/9/2009	TP
717	113	5/9/2009	TP
707	10, 104.1, 101, 102, 103X, 210, 203	12/5/2009	TP
709	225	12/5/2009	TP
710	008	12/5/2009	TP
715	507	12/5/2009	TP
713	170	12/5/2009	TP
711	170	12/5/2009	TP
705	1	12/5/2009	TP

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
WEST	5/31/2007	TP
WEST	12/21/2007	TP
WEST, ACM, Google	8/15/2008	TP
WEST, Google Scholar	5/9/2009	TP
WEST, NPL: ACM	12/5/2009	TP

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	4, 10, 104.1, 101, 102, 103X, 210, 203	12/5/2009	TP
709	202, 237, 224, 225, 227	12/5/2009	TP
715	507	12/12/2009	TP
710	008	12/5/2009	TP
711	170	12/5/2009	TP
713	170	12/5/2009	TP
705	1	12/4/2009	TP

/Thuy N Pardo/ Primary Examiner, Art Unit 2627
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